

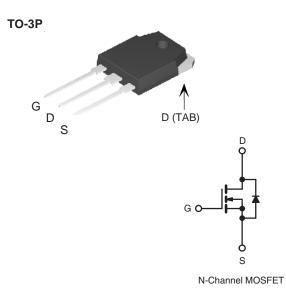
RoHS

COMPLIANT

K40J60-VB Datasheet

N-Channel 600V(D-S) Super Junction Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V) at T _J max.	600				
R _{DS(on)} at 25 °C (Ω)	$V_{GS} = 10 V$	0.06			
Q _g max. (nC)	273				
Q _{gs} (nC)	46				
Q _{gd} (nC)	79				
Configuration	Single				



FEATURES

- Low figure-of-merit (FOM) Ron x Qg
- Low input capacitance (C_{iss})
- Reduced switching and conduction losses
- Ultra low gate charge (Q_q)
- Avalanche energy rated (UIS)

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Industrial
 - Welding
 - Induction heating
 - Motor drives
 - Battery chargers
 - Renewable energy
 - Solar (PV inverters)

ABSOLUTE MAXIMUM RATINGS (T _C	= 25 °C, unle	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	600	v	
Gate-Source Voltage			V _{GS}	± 30		
Continuous Drain Current (T _J = 150 °C)	V _{GS} at 10 V	T _C = 25 °C T _C = 100 °C	1-	47		
		T _C = 100 °C	I _D	30	А	
Pulsed Drain Current ^a			I _{DM}	142		
Linear Derating Factor				3.3	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	1410	mJ	
Maximum Power Dissipation			PD	415	W	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +150	°C	
Drain-Source Voltage Slope	T _J = 125 °C		d\//dt	37) //mm	
Reverse Diode dV/dt ^d		dV/dt	9	V/ns		
Soldering Recommendations (Peak Temperature) ^c	for 10 s			300	°C	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature.

- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 Ω , I_{AS} = 10 A.
- c. 1.6 mm from case.
- d. $I_{SD} \leq I_D, \, dI/dt = 100$ A/µs, starting $T_J = 25 \ ^\circ C.$



THERMAL RESISTANCE RATI	NGS								
PARAMETER	SYMBOL	TYP. MAX.			UNIT				
Maximum Junction-to-Ambient	R _{thJA}	- 40			20.44				
Maximum Junction-to-Case (Drain)	R _{thJC}	- 0.3				°C/W			
SPECIFICATIONS ($T_J = 25 \text{ °C}$, u	1	se noted)				1	1		
PARAMETER	SYMBOL	TES	T CONDIT	IONS	MIN.	TYP.	MAX.	UNIT	
Static									
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D =	250 µA	600	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C,	$I_D = 1 \text{ mA}$	-	0.70	-	V/°C	
Gate-Source Threshold Voltage (N)	V _{GS(th)}	V _{DS} =	= V_{GS} , I_D =	250 µA	2	-	4	V	
Gate-Source Leakage	lass	$V_{GS} = \pm 20 V$ $V_{GS} = \pm 30 V$		-	-	± 100	nA		
Gate-Source Leakage	I _{GSS}			V	-	-	± 1	μA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 650 \text{ V}, V_{GS} = 0 \text{ V}$			-	-	1	μA	
Zero Gale Voltage Drain Gurrent		$V_{DS} = 520 V_{DS}$	$V_{DS} = 520 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 125 \text{ °C}$			-	25		
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 V$	I	_D = 24 A	-	0.06	-	Ω	
Forward Transconductance	9 _{fs}	$V_{DS} = 30 \text{ V}, \text{ I}_{D} = 24 \text{ A}$		-	16.7	-	s		
Dynamic									
Input Capacitance	C _{iss}		V _{GS} = 0 V,		-	5682	-		
Output Capacitance	C _{oss}	$V_{DS} = 100 V,$ f = 1 MHz		-	251	-	pF		
Reverse Transfer Capacitance	C _{rss}			-	1	-			
Effective Output Capacitance, Energy Related ^a	C _{o(er)}	V_{DS} = 0 V to 520 V, V_{GS} = 0 V		-	192	-			
Effective Output Capacitance, Time Related ^b	C _{o(tr)}			-	665	-			
Total Gate Charge	Qg				-	182	273		
Gate-Source Charge	Q _{gs}	$V_{GS} = 10 \text{ V}$ $I_D = 24 \text{ A}, V_{DS} = 520 \text{ V}$		-	46	-	nC		
Gate-Drain Charge	Q _{gd}				- 79			-	
Turn-On Delay Time	t _{d(on)}	V_{DD} = 520 V, I_D = 6 A, V_{GS} = 10 V, R_g = 9.1 Ω		-	47	94	ns		
Rise Time	t _r			-	87	131			
Turn-Off Delay Time	t _{d(off)}			-	156	234			
Fall Time	t _f			-	103	206			
Gate Input Resistance	R _g	f = 1 MHz, open drain		-	0.64	-	Ω		
Drain-Source Body Diode Characteristic	cs								
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	47	A		
Pulsed Diode Forward Current	I _{SM}			-	-	139			
Diode Forward Voltage	V _{SD}	T _J = 25 °C, I _S = 24 A, V _{GS} = 0 V		-	0.9	1.2	V		
Reverse Recovery Time	t _{rr}	$T_J = 25 \text{ °C}, I_F = I_S = 24 \text{ A},$ dl/dt = 100 A/µs, V _R = 25 V		-	753	1506	ns		
Reverse Recovery Charge	Q _{rr}			-	14	28	μC		
Reverse Recovery Current	I _{RRM}			-	28	-	A		

Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .



TYPCIAL CHARACTERISTICS (25 °C, unless otherwise noted)

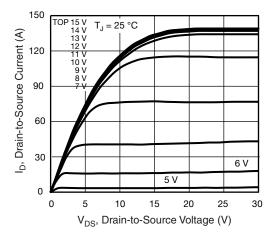


Fig. 1 - Typical Output Characteristics

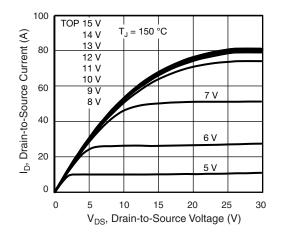


Fig. 2 - Typical Output Characteristics

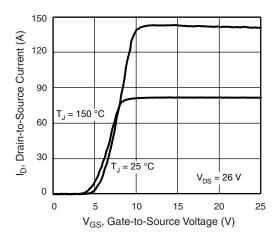


Fig. 3 - Typical Transfer Characteristics

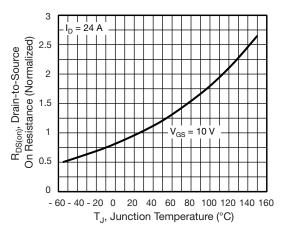


Fig. 4 - Normalized On-Resistance vs. Temperature

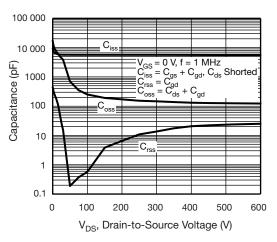


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

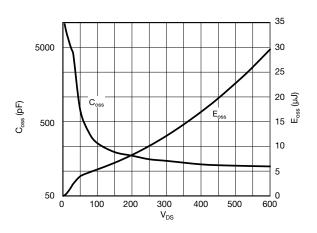


Fig. 6 - Coss and Eoss vs. VDS

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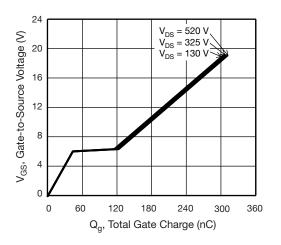


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

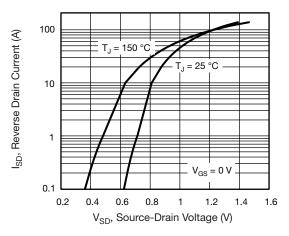


Fig. 8 - Typical Source-Drain Diode Forward Voltage

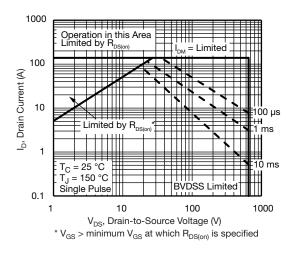
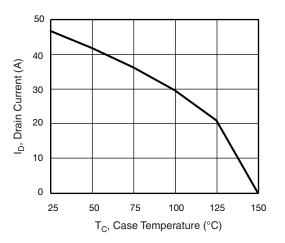


Fig. 9 - Maximum Safe Operating Area



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Fig. 10 - Maximum Drain Current vs. Case Temperature

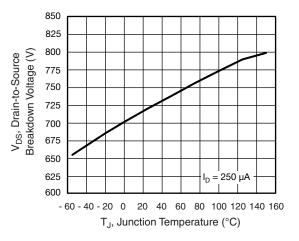


Fig. 11 - Temperature vs. Drain-to-Source Voltage

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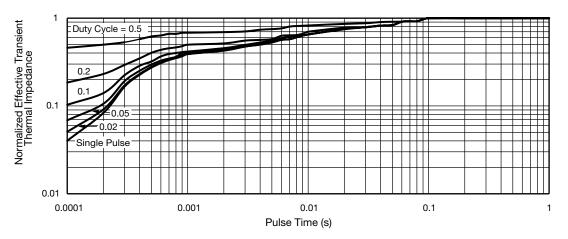


Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case

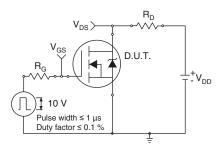


Fig. 13 - Switching Time Test Circuit

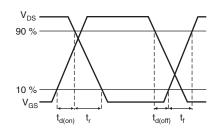


Fig. 14 - Switching Time Waveforms

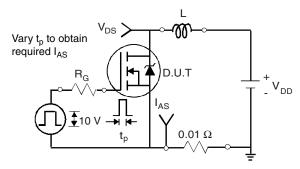


Fig. 15 - Unclamped Inductive Test Circuit

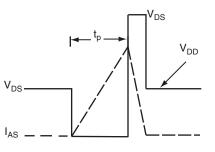


Fig. 16 - Unclamped Inductive Waveforms

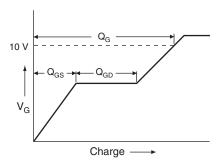


Fig. 17 - Basic Gate Charge Waveform

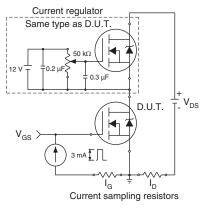


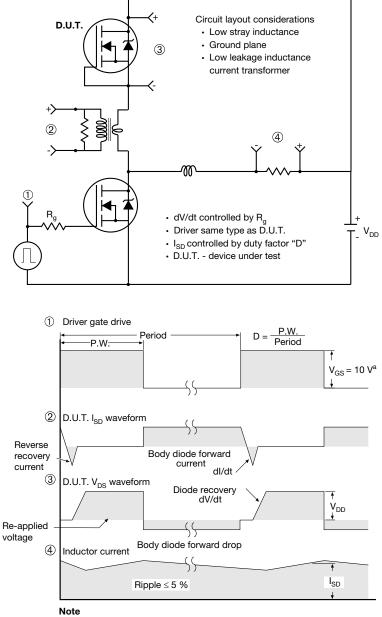
Fig. 18 - Gate Charge Test Circuit

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Peak Diode Recovery dV/dt Test Circuit



a. $V_{GS} = 5 V$ for logic level devices

Fig. 19 - For N-Channel



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